
 Substitute Form PTO-1449
 (Modified)

 U.S. Department of Commerce
 Patent and Trademark Office

 Attorney's Docket No.
 12406-003001

 Application No.
 09/221,789

**Information Disclosure Statement
 by Applicant**

(Use several sheets if necessary)

 Applicant
 Ulrike Reeh et al.

 Filing Date
 December 28, 1998

 Group Art Unit
 2815

U.S. Patent Documents

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
<i>[Signature]</i>	AA	3,453,604	07/1969	Geusic et al.			
	AB	3,573,568	04/1971	Siegel			
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	AI	4,599,537	07/08/1986	Yamashita			
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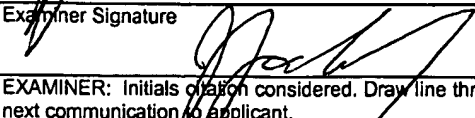
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
Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12406-003001	Application No. 09/221,789
Information Disclosure Statement by Applicant (Use several sheets if necessary)		Applicant Ulrike Reeh et al.	
		Filing Date December 28, 1998	Group Art Unit 2815
(37 CFR §1.98(b))			


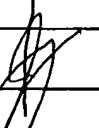
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	BB						

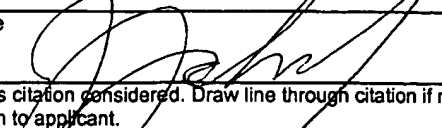
Foreign Patent Documents or Published Foreign Patent Applications								
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							Yes	No
	BC	1 007 825	10/31/1995	Belgium	E01F	G02B	Abstract Only	
	BD	0039017B1	08/28/1985	EPO			Abstract only	
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							Yes	No
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	CI	97/48138	12/18/1997	WIPO				

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	CJ	Möllmer et al., "Siemens SMT TOP-LED for Surface Mounting", <u>Siemens Components</u> , Bd. 26, No. 6, pp. 193-196 (1991)
	CK	Translation of Japanese Office Action Dated June 2, 2005
	CL	Notice of European Opposition Dated February 28, 2005
	CM	Six European Search Reports dated May 25, 2005
	CN	<i>In the Matter of Certain Light-Emitting Diodes and Products Containing Same</i> , Investigation No. 337-TA-512, "Notice of Commission Final Determination of No Violation of Section 337 as to One Patent and Determination to Remand the Investigation as Certain Other Patents," Dated August 10, 2005
	CO	<i>In the Matter of Certain Light-Emitting Diodes and Products Containing Same</i> , Investigation No. 337-TA-512, "Initial Determination on Violation of Section 337 and Recommended Determination on Remedy and Bond," (Public Version), Dated May 10, 2005
	CP	<i>In the Matter of Certain Light-Emitting Diodes and Products Containing Same</i> , Investigation No. 337-TA-512, "Commission Opinion," (Public Version), Dated August 29, 2005
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	CR	

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